

FAIRCHILD

SEMICONDUCTOR

April 2009

FDMS7672

N-Channel PowerTrench[®] MOSFET 30 V, $5.0 \text{ m}\Omega$

Features

- Max $r_{DS(on)} = 5.0 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 19 \text{ A}$
- Max $r_{DS(on)} = 6.9 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 15 \text{ A}$
- Advanced Package and Silicon design for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery. Provides Schottky-like performance with minimum EMI in sync buck converter applications
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

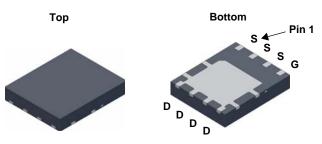


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- IMVP Vcore Switching for Notebook
- VRM Vcore Switching for Desktop and Server
- OringFET / Load Switch
- DC-DC Conversion



Power 56

D 5 4 G D 6 3 S D 7 2 S D 8 1 S

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain to Source Voltage			30	V
V _{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		28	
I _D	-Continuous (Silicon limited)	T _C = 25 °C		80	Α
	-Continuous	T _A = 25 °C	(Note 1a)	19	A
	-Pulsed			90	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	72	mJ
D	Power Dissipation	T _C = 25 °C		48	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7672	FDMS7672	Power 56	13 "	12 mm	3000 units

Units

Max

Тур

Electrical Characteristics T_J = 25 °C unless otherwise noted

BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25 °C		15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

Test Conditions

Min

On Characteristics

查询symbol S7672"供应商Parameter

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.25	2.0	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-7		mV/°C
		V _{GS} = 10 V, I _D = 19 A		3.6	5.0	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$		5.2	6.9	mΩ
	$V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}, T_J = 125 ^{\circ}\text{C}$		4.9	6.8		
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 19 A		64		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V	2225	2960	pF
Coss	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	685	910	рF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	90	130	pF
R_g	Gate Resistance		0.7	1.5	Ω

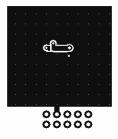
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		13	23	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 19 A,	5	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	25	40	ns
t _f	Fall Time		4	10	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	31	44	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V},$	14	19	nC
Q _{gs}	Gate to Source Charge	I _D = 19 A	7.6		nC
Q_{gd}	Gate to Drain "Miller" Charge		3.7		nC

Drain-Source Diode Characteristics

V	Course to Drain Diade Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A}$ (Note 2)	0.7	0.95	V	
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 19 \text{ A}$ (Note 2)	0.8	1.1	, v	
t _{rr}	Reverse Recovery Time		32	51	ns	
Q_{rr}	Reverse Recovery Charge		14	24	nC	
ta	Reverse Recovery Fall Time	I _F = 19 A, di/dt = 100 A/μs	15		nC	
t _b	Reverse Recovery Rise Time		17		nC	
S	Softness (t _b /t _a)		1.1			
t _{rr}	Reverse Recovery Time		26	42	ns	
Q _{rr}	Reverse Recovery Charge	$I_F = 19 \text{ A, di/dt} = 300 \text{ A/}\mu\text{s}$	25	40	nC	

^{1.} R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

^{3.} E_{AS} of 72 mJ is based on starting T_{J} = 25 °C, L = 1 mH, I_{AS} = 12 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 17 A.

^{4.} As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

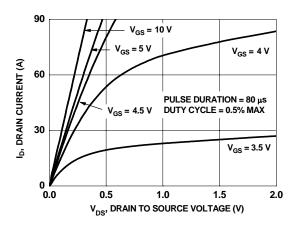


Figure 1. On Region Characteristics

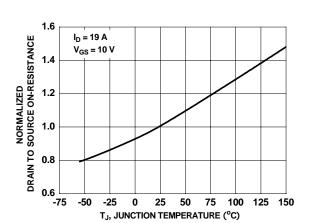


Figure 3. Normalized On Resistance vs Junction Temperature

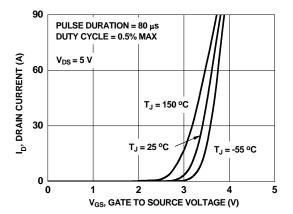


Figure 5. Transfer Characteristics

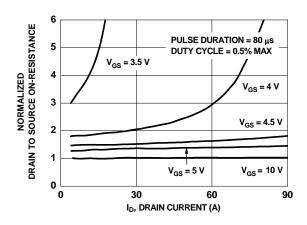


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

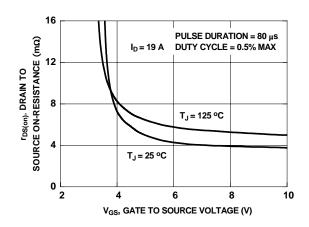


Figure 4. On-Resistance vs Gate to Source Voltage

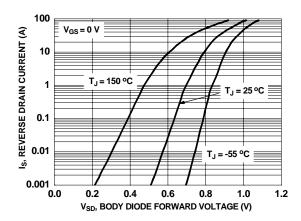


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

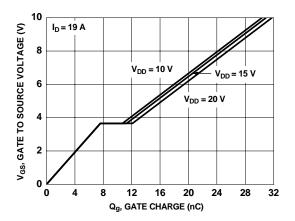


Figure 7. Gate Charge Characteristics

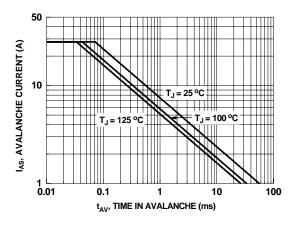


Figure 9. Unclamped Inductive Switching Capability

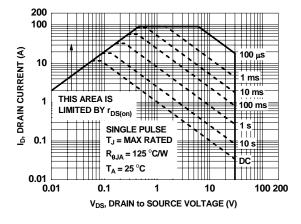


Figure 11. Forward Bias Safe Operating Area

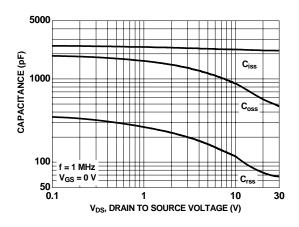


Figure 8. Capacitance vs Drain to Source Voltage

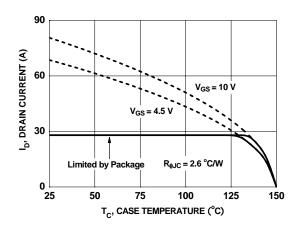


Figure 10. Maximum Continuous Drain Current vs Case Temperature

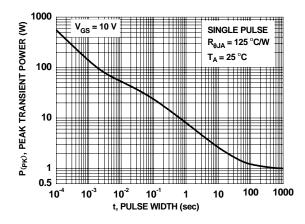


Figure 12. Single Pulse Maximum Power Dissipation

查询"FDMS7672"供应商 Typical Characteristics $T_J = 25$ °C unless otherwise noted

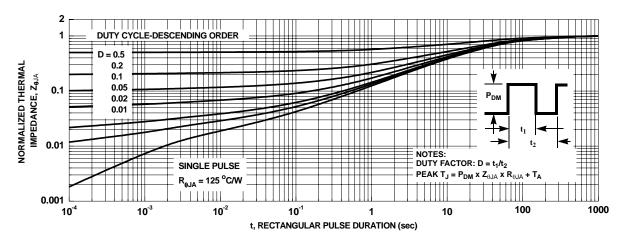


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

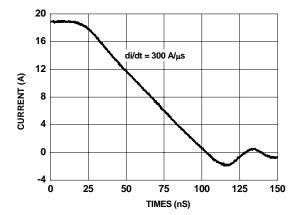
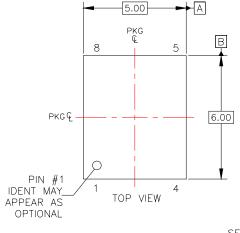
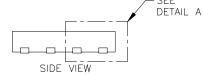
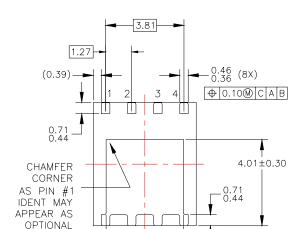


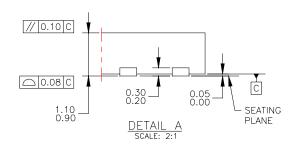
Figure 14. Body Diode Reverse Recovery **Characteristics**

Dimensional Outline and Pad Layout







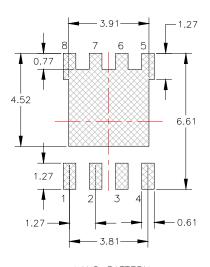


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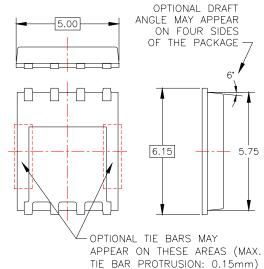
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BOTTOM VIEW

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LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002.
- ALL DIMENSIONS ARE IN MILLIMETERS.
 DIMENSIONS DO NOT INCLUDE BURRS
 OR MOLD FLASH, MOLD FLASH OR
 BURRS DOES NOT EXCEED 0.10MM.
 DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M—1994.
- DRAWING FILE NAME: PQFN08AREV4





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